

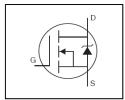
Features

- Advanced Planar Technology
- Low On-Resistance
- Logic Level Gate Drive
- Dynamic dv/dt Rating
- 150°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

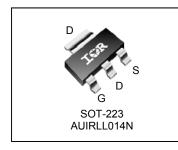
Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications





V _{DSS}	55V
R _{DS(on)} max.	0.14Ω
I _D	2.0A



G	D	S
Gate	Drain	Source

Boss nort number	Package Type Standard Pack		Orderable Part Number	
Base part number	Package Type	Form Quantity		Orderable Part Number
AUIRLL014N	SOT-223	Tape and Reel	2500	AUIRLL014NTR

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V ®	2.8	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V ®	2.0	A
I _D @ T _A = 70°C Continuous Drain Current, V _{GS} @ 10V S		1.6	
I _{DM}	Pulsed Drain Current ①	16	
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) ©	2.1	10/
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) S	1.0	W
	Linear Derating Factor (PCB Mount) S	8.3	mW/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	32	mJ
I _{AR}	Avalanche Current ①	2.0	А
E _{AR}	Repetitive Avalanche Energy ①⑤	0.1	mJ
dv/dt	Peak Diode Recovery dv/dt ③	7.2	V/ns
T_J	Operating Junction and	-55 to + 150	°C
T _{STG} Storage Temperature Range			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state) ©	90	120	°CAM
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state) ®	50	60	°C/W

 $\label{eq:hexpectation} \mbox{HEXFET} \mbox{\ensuremath{\mathbb{R}}} \mbox{ is a registered trademark of Infineon}.$

^{*}Qualification standards can be found at www.infineon.com



Static @ $T_J = 25$ °C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.015		V/°C	Reference to 25 $^{\circ}$ C, I _D = 1mA
				0.14		$V_{GS} = 10V, I_D = 2.0A $ ④
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.20	Ω	$V_{GS} = 5.0V, I_D = 1.2A$ @
, ,				0.28		V _{GS} = 4.0V, I _D = 1.0A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	2.3			S	$V_{DS} = 25V, I_{D} = 1.0A$
1	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$
I _{DSS}				250		$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100		V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 9.5	14		I _D = 2.0A
Q_{gs}	Gate-to-Source Charge	 1.1	1.7	nC	V _{DS} = 44V
Q_{gd}	Gate-to-Drain Charge	 3.0	4.4		V _{GS} = 10V, See Fig 6 and 9 ④
$t_{d(on)}$	Turn-On Delay Time	 5.1			$V_{DD} = 28V$
t _r	Rise Time	 4.9		no	$I_{D} = 2.0A$
$t_{d(off)}$	Turn-Off Delay Time	 14		ns	$R_G = 6.0\Omega$
t _f	Fall Time	 2.9			R_D = 14 Ω , See Fig. 10 @
C_{iss}	Input Capacitance	 230			$V_{GS} = 0V$
Coss	Output Capacitance	 66		pF	$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	 30			f = 1.0MHz, See Fig.5

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			1.3		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			16		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.0	V	$T_J = 25^{\circ}C, I_S = 2.0A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		41	61	ns	$T_J = 25^{\circ}C$, $I_F = 2.0A$,
Q _{rr}	Reverse Recovery Charge		73	110	nC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	n time is	negligil	ble (turn-on is dominated by LS+LD)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② $V_{DD} = 25V$, starting $T_J = 25$ °C, L = 4.0mH, $R_G = 25\Omega$, $I_{AS} = 4.0$ A. (See fig. 12)
- $\label{eq:local_local_local_local} \mbox{ } \$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ When mounted on FR-4 board using minimum recommended footprint.
- © When mounted on 1 inch square copper board, for comparison with other SMD devices.



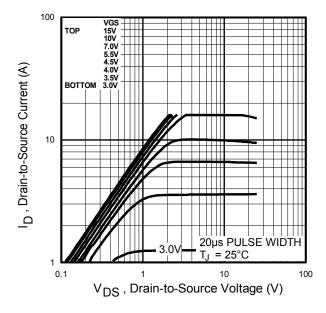


Fig. 1 Typical Output Characteristics

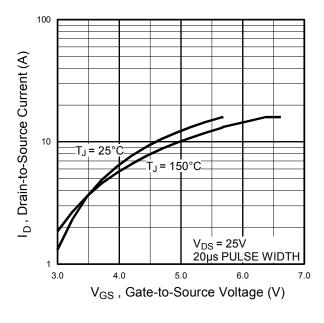


Fig. 3 Typical Transfer Characteristics

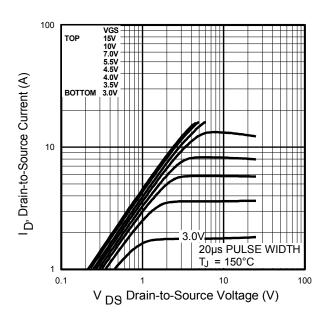


Fig. 2 Typical Output Characteristics

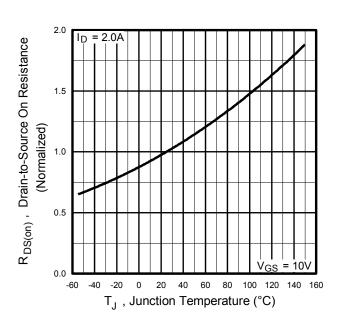


Fig. 4 Normalized On-Resistance vs. Temperature



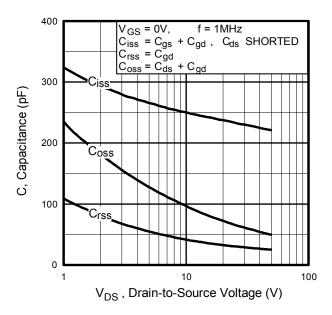


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

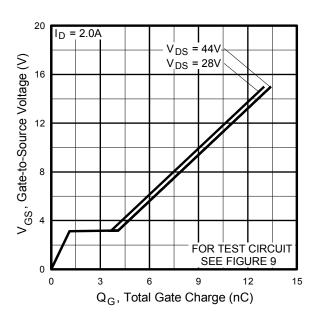


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

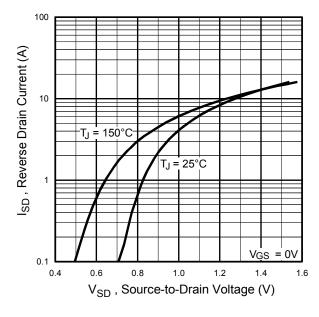


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

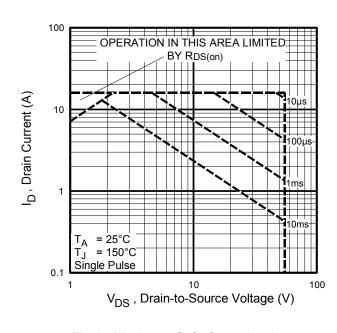


Fig 8. Maximum Safe Operating Area

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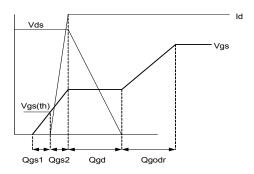


Fig 9a. Basic Gate Charge Waveform

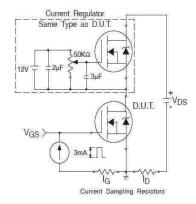


Fig 9b. Gate Charge Test Circuit

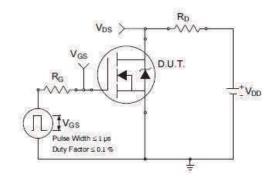


Fig 10a. Switching Time Test Circuit

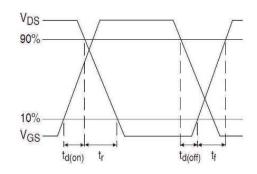


Fig 10b. Switching Time Waveforms

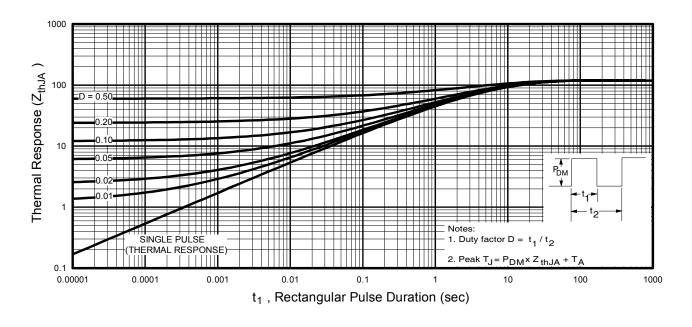


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



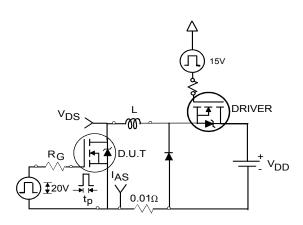


Fig 12a. Unclamped Inductive Test Circuit

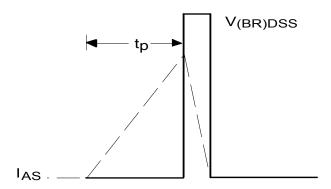


Fig 12b. Unclamped Inductive Waveforms

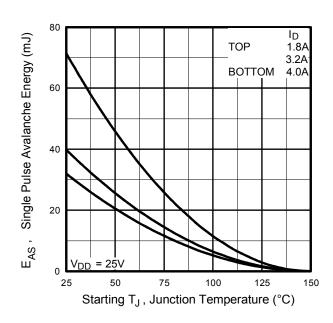
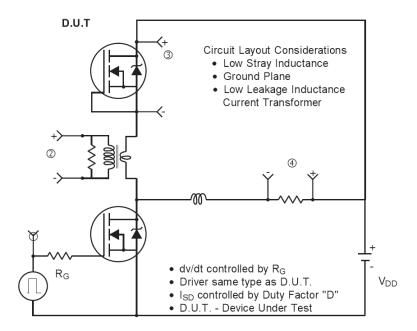
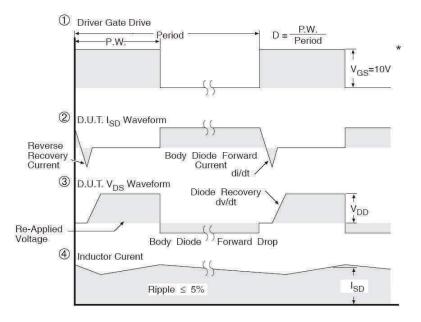


Fig 12c. Maximum Avalanche Energy Vs. Drain Current



Peak Diode Recovery dv/dt Test Circuit





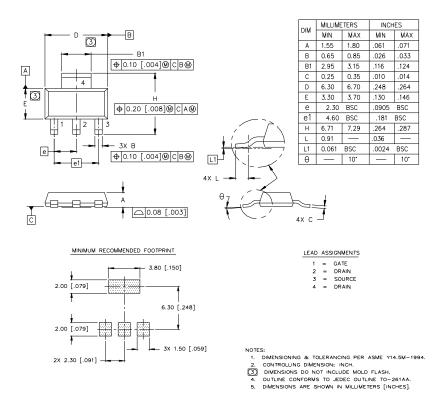
^{*} V_{GS} = 5V for Logic Level Devices

Fig 13. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

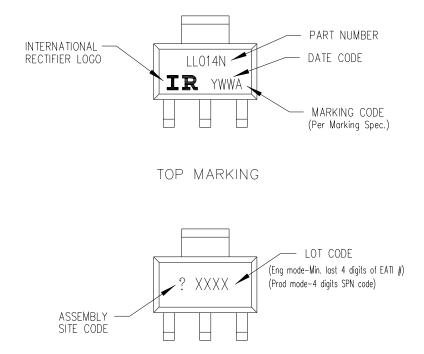
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SOT-223 (TO-261AA) Package Outline (Dimensions are shown in millimeters (inches)



SOT-223(TO-261AA) Part Marking Information



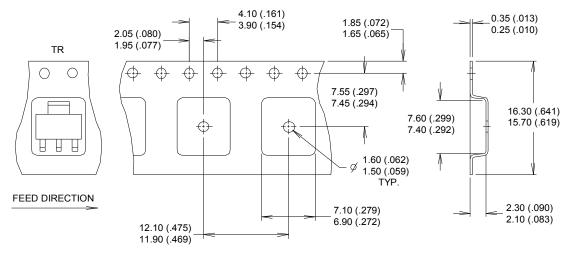
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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BOTTOM MARKING

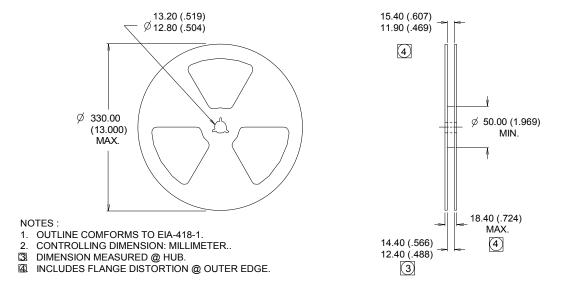


SOT-223(TO-261AA) Tape and Reel (Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
- 3. EACH Ø330.00 (13.00) REEL CONTAINS 2,500 DEVICES.



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive					
		(per AEC-Q101)					
Qualificati	ion Level	Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture	Sensitivity Level	SOT-223	MSL1				
	Machine Madel	Class M1A (+/- 50V) [†]					
	Machine Model	AEC-Q101-002					
FOD	Lluman Dady Madal	Class H0 (+/- 250V) [†]					
ESD	Human Body Model	AEC-Q101-001					
	Charred Davis Madel	Class C5 (+/- 1125V) [†]					
	Charged Device Model	AEC-Q101-005					
RoHS Compliant		Yes					

[†] Highest passing voltage.

Revision History

Date	Comments		
3/25/2014	 Added "Logic Level Gate Drive" bullet in the features section on page 1 Updated part marking on page 8 Updated data sheet with new IR corporate template 		
10/29/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. 		

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